## Notice of References Cited Application/Control No. 09/650,198 Examiner Uyen-Chau N. Le Applicant(s)/Patent Under Reexamination COK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,755,935	09-1973	Annenberg, Maurice	283/94
	В	US-4,151,667	05-1979	Idelson et al.	283/92
	С	US-6,109,526	08-2000	Ohanian et al.	235/462.45
	D	US-6,734,887	05-2004	Field, Gary	235/494
	Е	US-5,337,361	08-1994	Wang et al.	235/462.11
	F	US-5,984,366	11-1999	Priddy, Dennis G.	235/380
	G	US-5,646,388	07-1997	D'Entremont et al.	235/380
	н	US-5,490,217	02-1996	Wang et al.	235/462.09
	1	US-4,818,852	04-1989	Haddock et al.	235/488
	J	US-4,213,038	07-1980	Silverman et al.	235/382
	К	US-4,745,268	05-1988	Drexler, Jerome	235/487
	L	US-6,252,963	06-2001	Rhoads, Geoffrey B.	380/54
	М	US-6,610,386	08-2003	Williams et al.	283/113

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.